Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	I_D
150V	5.2mΩ@10V	185A

合肥矽普半导体
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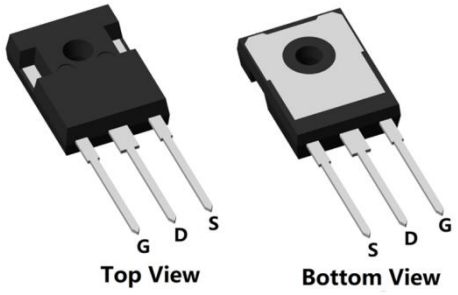
Feature

- Fast Switching
- Low Gate Charge and Rdson
- Advanced Split Gate Trench Technology
- 100% Single Pulse avalanche energy Test

Applications

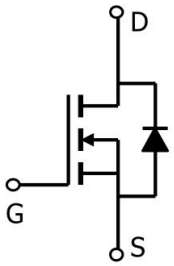
- Power switching application
- DC-DC Converter
- Power Management

Package

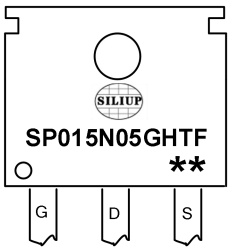


TO-247(1:G 2:D 3:S)

Circuit diagram



Marking



SP015N05GHTF **:Product code**
****** **:Week code**

Order Information

Device	Package	Unit/Tube
SP015N05GHTF	TO-247	30

Absolute maximum ratings (Ta=25℃,unless otherwise noted)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	150	V
Gate-Source Voltage	V_{GS}	±20	V
Continuous Drain Current (Tc=25℃)	I_D	185	A
Continuous Drain Current (Tc=100℃)	I_D	125	A
Pulsed Drain Current	I_{DM}	740	A
Single Pulse Avalanche Energy[1]	E_{AS}	1225	mJ
Power Dissipation (Tc=25℃)	P_D	335	W
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	0.37	℃/W
Storage Temperature Range	T_{STG}	-55 to 150	℃
Operating Junction Temperature Range	T_J	-55 to 150	℃

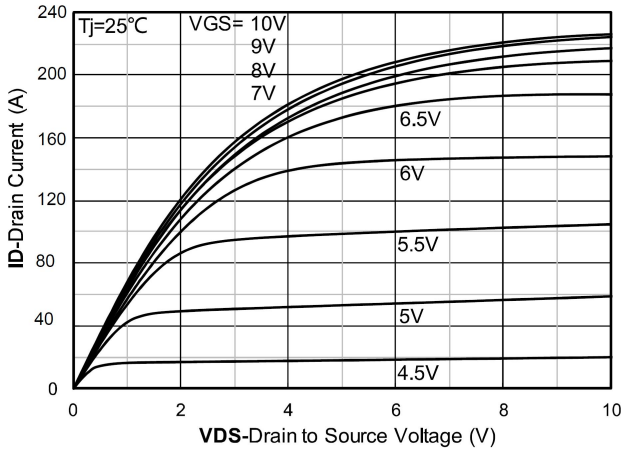
Electrical characteristics (Ta=25℃, unless otherwise noted)

Characteristics	Symbol	Test Condition	Min	Typ	Max	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	ID = 250μA, VGS = 0V	150	-	-	V
Drain Cut-Off Current	I_{DSS}	VDS = 120V, VGS = 0V	-	-	1	μA
Gate Leakage Current	I_{GSS}	VGS = ±20V, VDS = 0V	-	-	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	VDS = VGS, ID = 250μA	2.0	3.0	4.0	V
Drain-Source ON Resistance	$R_{DS(ON)}$	VGS = 10V, ID = 20A	-	5.2	6.5	mΩ
Dynamic Characteristics						
Input Capacitance	C_{iss}	VDS = 75V, VGS = 0V, f = 1.0MHz	-	5450	-	pF
Output Capacitance	C_{oss}		-	690	-	
Reverse Transfer Capacitance	C_{rss}		-	26	-	
Total Gate Charge	Q_g	VDS = 75V, VGS = 10V, ID=20A	-	78	-	nC
Gate-Source Charge	Q_{gs}		-	34	-	
Gate-Drain Charge	Q_{gd}		-	22	-	
Switching Characteristics						
Turn-On Delay Time	$t_{d(on)}$	VGS = 10V, VDS = 75V, ID = 20A, RG = 3Ω	-	24	-	nS
Rise Time	t_r		-	35	-	
Turn-Off Delay Time	$t_{d(off)}$		-	46	-	
Fall Time	t_f		-	15	-	
Drain-Source Body Diode Characteristics						
Source-Drain Diode Forward Voltage	V_{SD}	I_S = 1A, VGS = 0V	-	-	1.2	V
Maximum Body-Diode Continuous Current	I_S		-	-	185	A
Body Diode Reverse Recovery Time	Trr	I_S = 15A, di/dt=100A/us, TJ=25℃	-	108	-	nS
Body Diode Reverse Recovery Charge	Qrr		-	312	-	nC

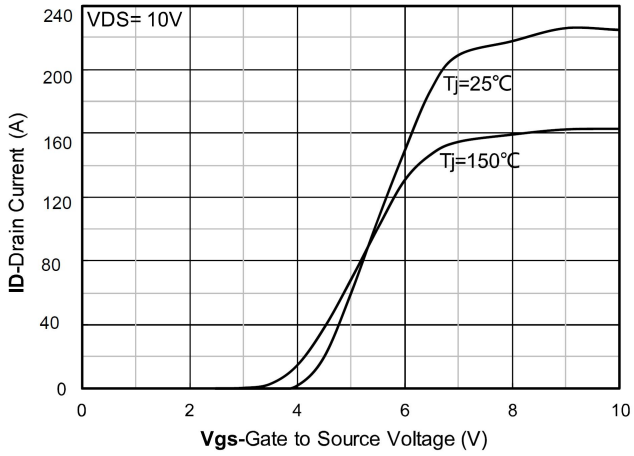
Note :

1. The test condition is VDD=75V,VGS=10V,L=0.5mH,RG=25Ω;

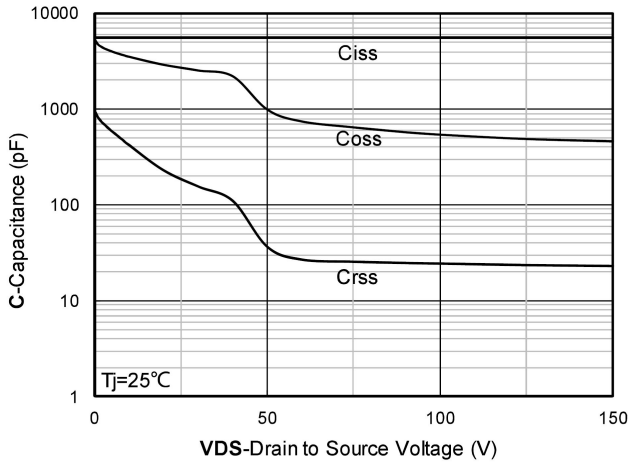
Typical Characteristics



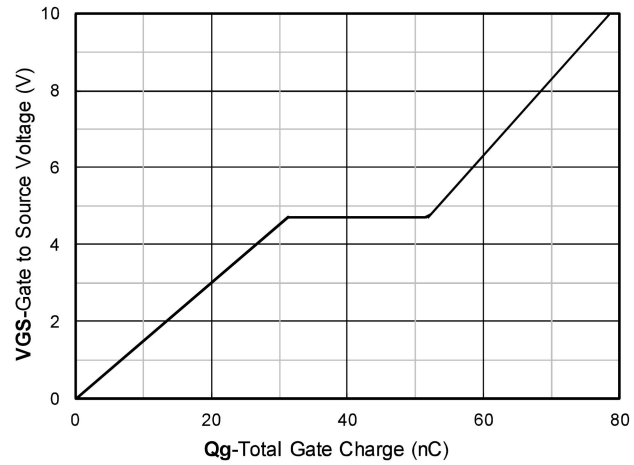
Output Characteristics typical values



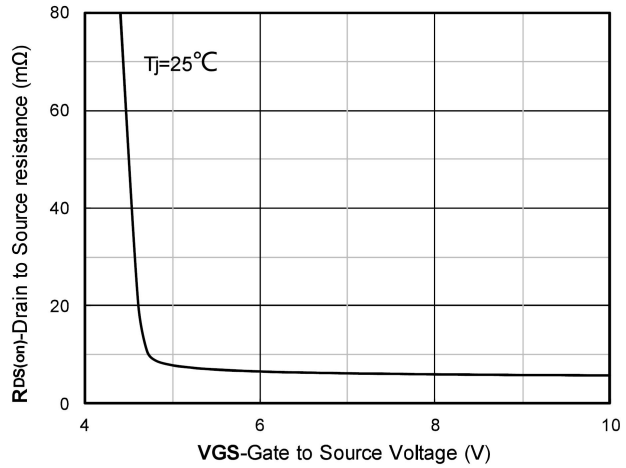
Transfer Characteristics typical values



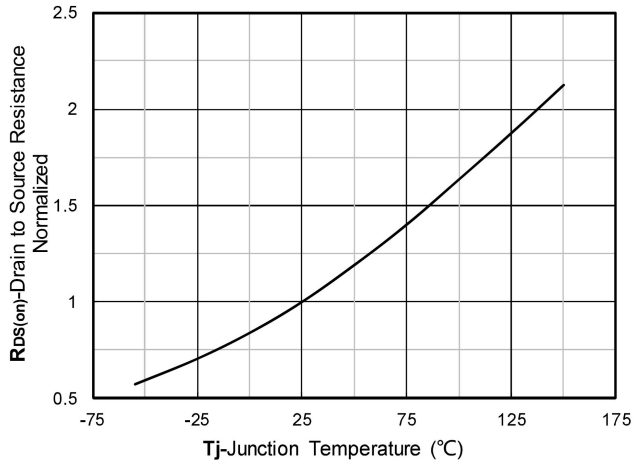
Capacitance Characteristics typical values



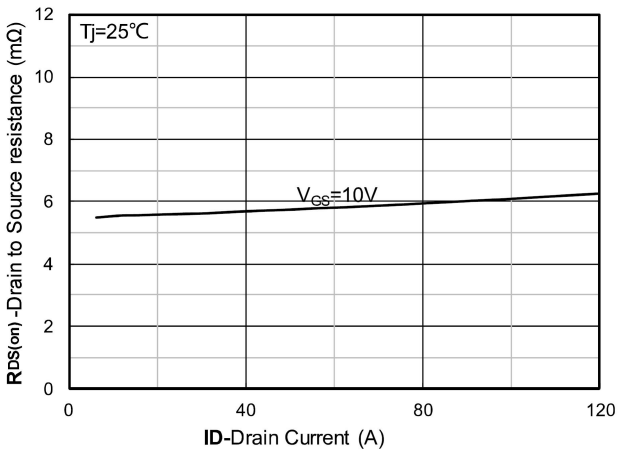
Gate Charge typical values



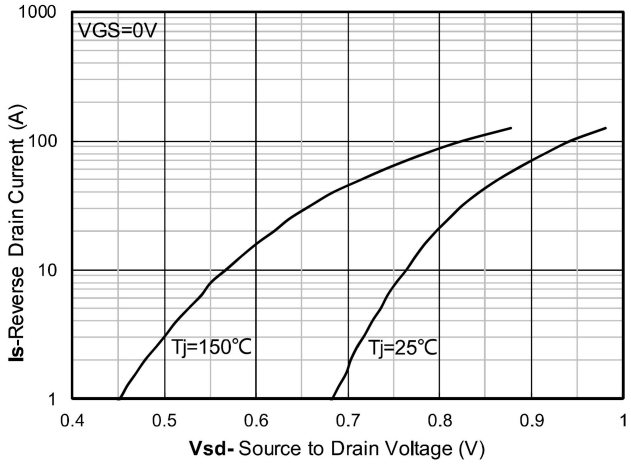
On-Resistance vs Gate to Source Voltage typical values



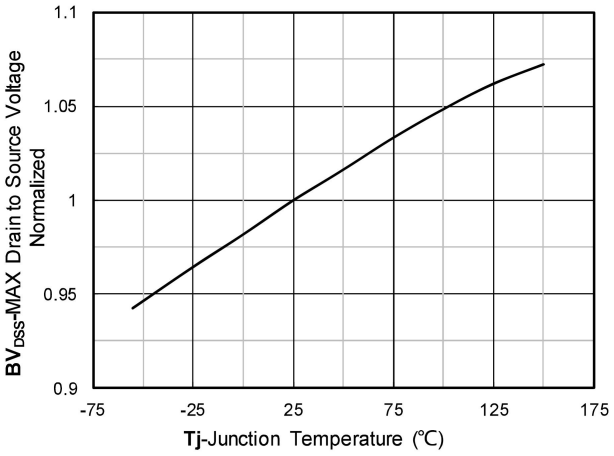
Normalized On-Resistance



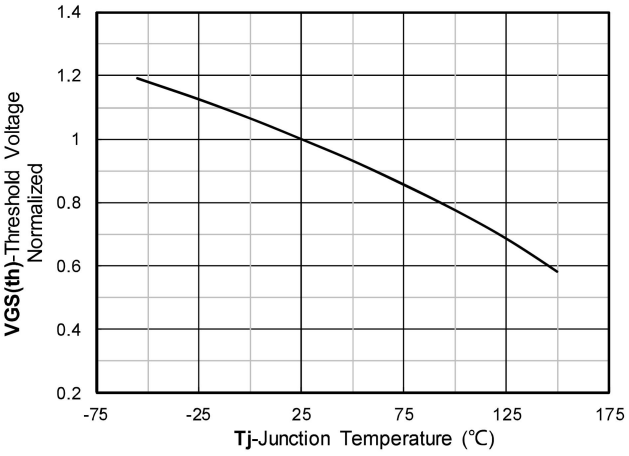
RDS(on) VS Drain Current typical values



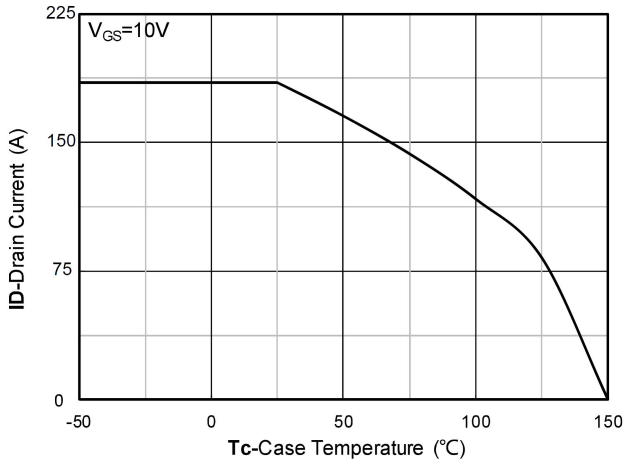
Forward characteristics of reverse diode typical values



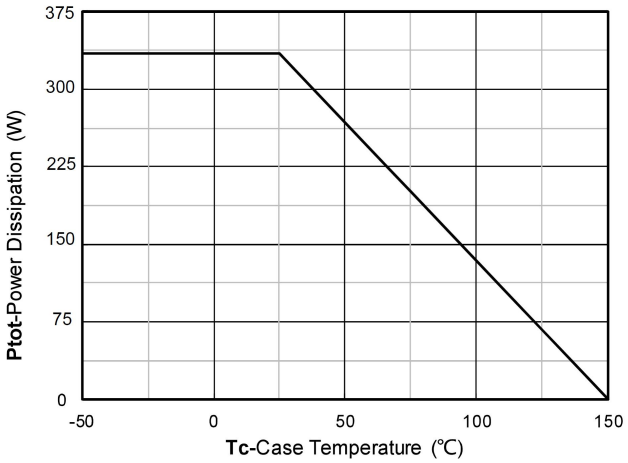
Normalized breakdown voltage



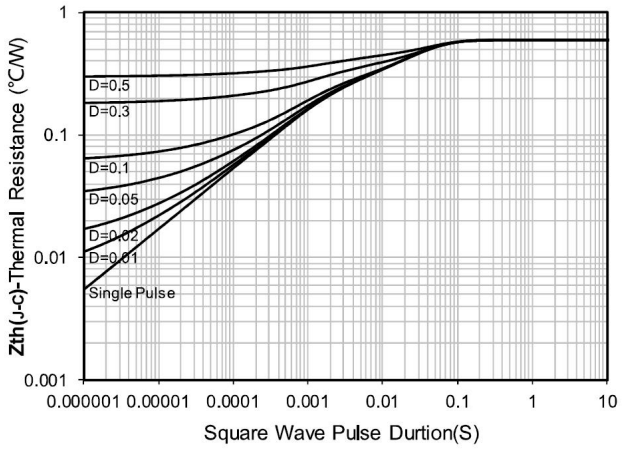
Normalized Threshold voltage



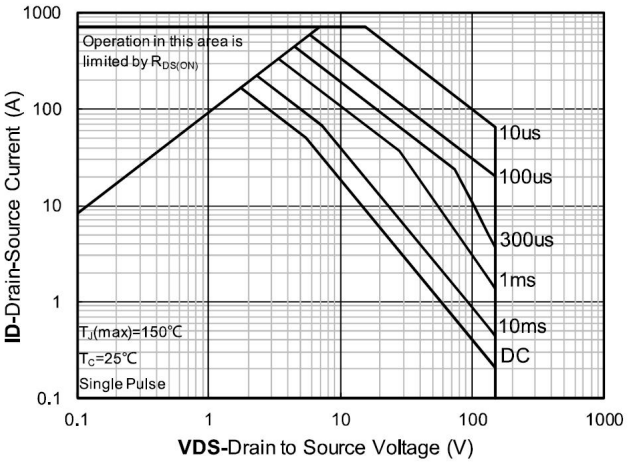
Current dissipation



Power dissipation

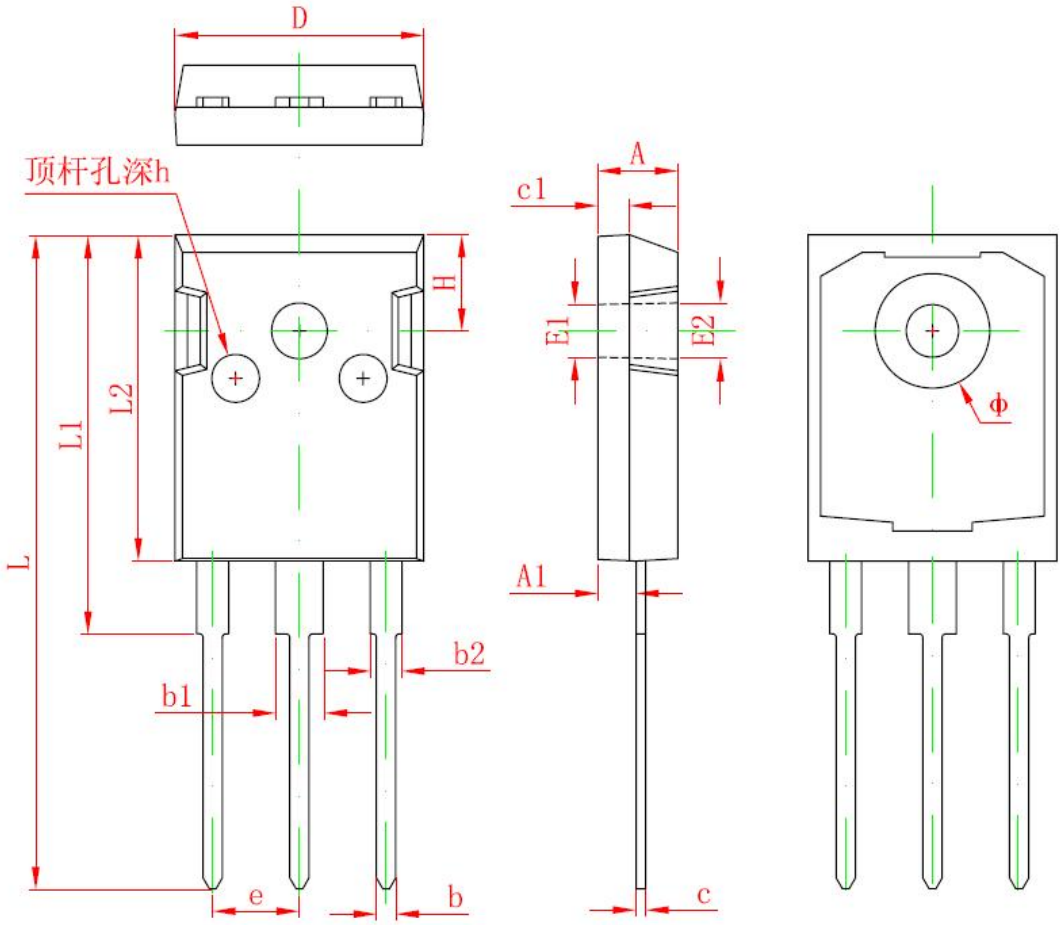


Maximum Transient Thermal Impedance



Safe Operation Area

TO-247 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.850	5.150	0.191	0.200
A1	2.200	2.600	0.087	0.102
b2	1.800	2.200	0.071	0.087
b	1.000	1.400	0.039	0.055
b1	2.800	3.200	0.110	0.126
c	0.500	0.700	0.020	0.028
c1	1.900	2.100	0.075	0.083
D	15.450	15.750	0.608	0.620
E1	3.500 REF.		0.138 REF.	
E2	3.600 REF.		0.142 REF.	
L	40.900	41.300	1.610	1.626
L1	24.800	25.100	0.976	0.988
L2	20.300	20.600	0.799	0.811
Φ	7.100	7.300	0.280	0.287
e	5.450 TYP.		0.215 TYP.	
H1	5.980 REF.		0.235 REF.	
h	0.000	0.300	0.000	0.012